SLIS044A – NOVEMBER 1994 – REVISED SEPTEMBER 1995

**D PACKAGE** 

(TOP VIEW)

Low r<sub>DS(on)</sub>... 0.6 Ω Typ
 Voltage Output... 60 V
 Input Protection Circuitry... 18 V
 Pulsed Current... 3 A Per Channel
 Extended ESD Capability... 4000 V

### description

The TPIC5323L is a monolithic gate-protected logic-level power DMOS array that consists of three electrically isolated independent N-channel

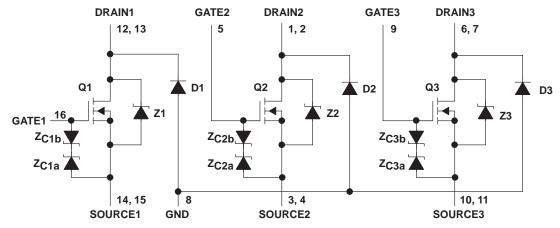
**Direct Logic-Level Interface** 

16 GATE1 DRAIN2 15 SOURCE1 DRAIN2 1 2 SOURCE2 3 14 SOURCE1 SOURCE2 13 DRAIN1 GATE2 1 5 12 DRAIN1 DRAIN3 [ 11 SOURCE3 DRAIN3 7 10 SOURCE3 9 ☐ GATE3 GND [

enhancement-mode DMOS transistors. Each transistor features integrated high-current zener diodes ( $Z_{CXa}$  and  $Z_{CXb}$ ) to prevent gate damage in the event that an overstress condition occurs. These zener diodes also provide up to 4000 V of ESD protection when tested using the human-body model of a 100-pF capacitor in series with a 1.5-k $\Omega$  resistor.

The TPIC5323L is offered in a standard 16-pin small-outline surface-mount (D) package and is characterized for operation over the case temperature of  $-40^{\circ}$ C to  $125^{\circ}$ C.

### schematic



NOTE A: For correct operation, no terminal can be taken below GND.

# TPIC5323L 3-CHANNEL INDEPENDENT GATE-PROTECTED

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### absolute maximum ratings over operating case temperature range (unless otherwise noted)†

Drain-to-source voltage, V <sub>DS</sub>	60 V
Source-to-GND voltage	100 V
Drain-to-GND voltage	100 V
Gate-to-source voltage range, V <sub>GS</sub>	–9 V to 18 V
Continuous drain current, each output, T <sub>C</sub> = 25°C	1 A
Continuous source-to-drain diode current, T <sub>C</sub> = 25°C	1 A
Pulsed drain current, each output, $I_{max}$ , $T_C = 25^{\circ}C$ (see Note 1 and Figure 15)	3 A
Continuous gate-to-source zener diode current, T <sub>C</sub> = 25°C	±50 mA
Pulsed gate-to-source zener diode current, T <sub>C</sub> = 25°C	±500 mA
Single-pulse avalanche energy, E <sub>AS</sub> , T <sub>C</sub> = 25°C (see Figures 4 and 16)	22.5 mJ
Continuous total power dissipation, $T_C = 25^{\circ}C$ (see Figure 15)	1.09 W
Operating virtual junction temperature range, T <sub>J</sub>	40°C to 150°C
Operating case temperature range, T <sub>C</sub>	40°C to 125°C
Storage temperature range, T <sub>stq</sub>	−65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Pulse duration = 10 ms, duty cycle = 2%



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# electrical characteristics, $T_C = 25^{\circ}C$ (unless otherwise noted)

	PARAMETER	TEST COND	MIN	TYP	MAX	UNIT	
V(BR)DSX	Drain-to-source breakdown voltage	$I_D = 250  \mu A$ ,	V <sub>GS</sub> = 0	60			V
V <sub>GS(th)</sub>	Gate-to-source threshold voltage	$I_D = 1 \text{ mA},$ $V_{DS} = V_{GS},$ See Figure 5		1.5	1.8	2.2	٧
V <sub>(BR)</sub> GS	Gate-to-source breakdown voltage	I <sub>GS</sub> = 250 μA		18			V
V <sub>(BR)</sub> SG	Source-to-gate breakdown voltage	I <sub>SG</sub> = 250 μA		9			V
V <sub>(BR)</sub>	Reverse drain-to-GND breakdown voltage (across D1, D2, D3)	Drain-to-GND curren	t = 250 μA	100			V
V <sub>DS(on)</sub>	Drain-to-source on-state voltage	I <sub>D</sub> = 1 A, See Notes 2 and 3	V <sub>GS</sub> = 5 V,		0.6	0.7	V
V <sub>F</sub> (SD)	Forward on-state voltage, source-to-drain	I <sub>S</sub> = 1 A, V <sub>GS</sub> = 0 (Z1, Z2, Z3) See Notes 2 and 3 and			0.9	1.1	V
VF	Forward on-state voltage, GND-to-drain	I <sub>D</sub> = 1 A (D1, D2, D3), See Notes 2 and 3			4		V
Inno	Zero-gate-voltage drain current	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0	T <sub>C</sub> = 25°C		0.05	1	μΑ
IDSS			T <sub>C</sub> = 125°C		0.5	10	μΑ
IGSSF	Forward-gate current, drain short circuited to source	V <sub>GS</sub> = 15 V,	$V_{DS} = 0$		20	200	nA
IGSSR	Reverse-gate current, drain short circuited to source	$V_{SG} = 5 V$ ,	$V_{DS} = 0$		10	100	nA
lu	Leakage current, drain-to-GND	V <sub>DGND</sub> = 48 V	T <sub>C</sub> = 25°C		0.05	1	1 μA
likg	Leakage current, drain-to-OND	VDGND = 40 V	T <sub>C</sub> = 125°C		0.5	10	μΑ
IDC(on)	Static drain-to-source on-state resistance	V <sub>GS</sub> = 5 V, I <sub>D</sub> = 1 A,	T <sub>C</sub> = 25°C		0.6	0.65	Ω
rDS(on)	Static drain-to-source on-state resistance	See Notes 2 and 3 and Figures 6 and 7	T <sub>C</sub> = 125°C		0.85	0.9	32
9fs	Forward transconductance	V <sub>DS</sub> = 15 V, See Notes 2 and 3 a	I <sub>D</sub> = 500 mA, nd Figure 9	0.89	1.06		S
C <sub>iss</sub>	Short-circuit input capacitance, common source				107	137	
Coss	Short-circuit output capacitance, common source	$V_{DS} = 25 \text{ V},$	$V_{GS} = 0$ ,		71	89	pF
C <sub>rss</sub>	Short-circuit reverse transfer capacitance, common source	f = 1 MHz,	See Figure 11		22	28	рі 

NOTES: 2. Technique should limit  $T_J - T_C$  to 10°C maximum.

# source-to-drain and GND-to-drain diode characteristics, $T_C$ = 25°C

	PARAMETER	TEST CONDITIONS				TYP	MAX	UNIT
	Develope receivers time		V <sub>DS</sub> = 48 V,	Z1, Z2, and Z3		75		
t <sub>rr</sub> Reverse-recovery time	$I_S = 500 \text{ mA},$	D1, D2, and D3		190		ns		
Q <sub>RR</sub> Total diode charge	VGS = 0, di/di See Figures 1 and 14	$di/dt = 100 A/\mu s$ ,	Z1, Z2, and Z3		0.08			
		D1, D2, and D3		0.85		μC		

<sup>3.</sup> These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

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### resistive-load switching characteristics, T<sub>C</sub> = 25°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
td(on)	Turn-on delay time			34	50	
td(off)	Turn-off delay time	$V_{DD} = 25 \text{ V},  R_L = 50 \Omega,  t_{r1} = 10 \text{ ns},$		50	70	no
t <sub>r2</sub>	Rise time	t <sub>f1</sub> = 10 ns, See Figure 2		20	30	ns
t <sub>f2</sub>	Fall time			15	25	
Qg	Total gate charge			2	2.45	
Q <sub>gs(th)</sub>	Threshold gate-to-source charge	V <sub>DS</sub> = 48 V, I <sub>D</sub> = 500 mA, V <sub>GS</sub> = 5 V, See Figure 3		0.3	0.95	nC
Q <sub>gd</sub>	Gate-to-drain charge	Geo i iguito o		1.2	1.48	
L <sub>D</sub>	Internal drain inductance			5		nH
LS	Internal source inductance			5		ш
Rg	Internal gate resistance			0.25		Ω

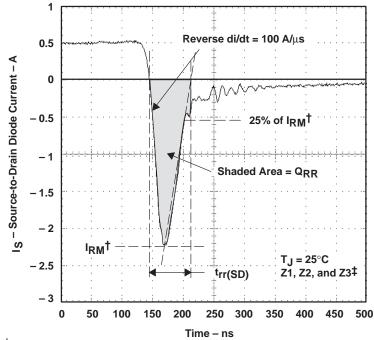
### thermal resistance

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	See Notes 4 and 7		115		
$R_{\theta JB}$	Junction-to-board thermal resistance	See Notes 5 and 7		64		°C/W
$R_{\theta JP}$	Junction-to-pin thermal resistance	See Notes 6 and 7		33		

NOTES: 4. Package mounted on an FR4 printed-circuit board with no heatsink.

- 5. Package mounted on a 24 in<sup>2</sup>, 4-layer FR4 printed-circuit board.
- 6. Package mounted in intimate contact with infinite heatsink.
- 7. All outputs with equal power

### PARAMETER MEASUREMENT INFORMATION



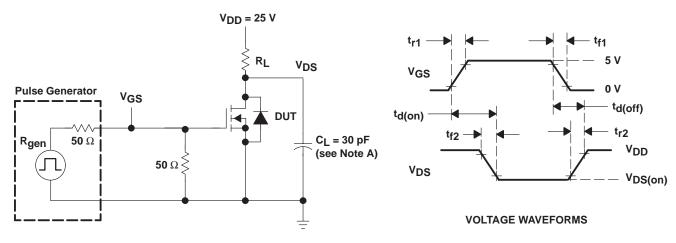
<sup>†</sup>I<sub>RM</sub> = maximum recovery current

Figure 1. Reverse-Recovery-Current Waveform of Source-to-Drain Diode



<sup>&</sup>lt;sup>‡</sup>The above waveform is representative of D1, D2, and D3 in shape only.

## PARAMETER MEASUREMENT INFORMATION



**TEST CIRCUIT** 

NOTE A: CL includes probe and jig capacitance.

Figure 2. Resistive-Switching Test Circuit and Voltage Waveforms

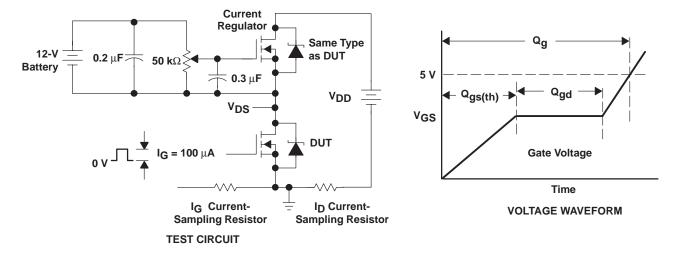
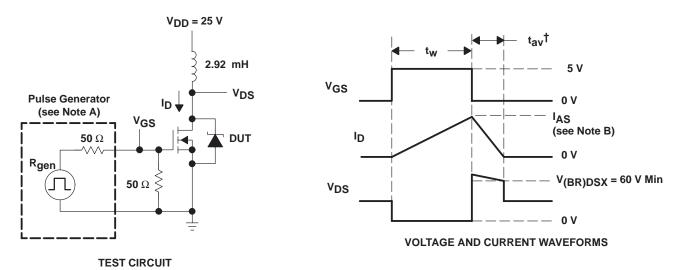


Figure 3. Gate-Charge Test Circuit and Waveform

### PARAMETER MEASUREMENT INFORMATION



† Non-JEDEC symbol for avalanche time

NOTES: A. The pulse generator has the following characteristics:  $t_r \le 10$  ns,  $t_f \le 10$  ns,  $Z_O = 50 \Omega$ .

B. Input pulse duration  $(t_W)$  is increased until peak current  $I_{AS} = 3 \text{ A}$ .

Energy test level is defined as  $E_{AS} = \frac{I_{AS} \times V_{(BR)DSX} \times t_{av}}{2} = 22.5 \text{ mJ}$ , where  $t_{av} = \text{avalanche time}$ .

Figure 4. Single-Pulse Avalanche-Energy Test Circuit and Waveforms

### TYPICAL CHARACTERISTICS

# **GATE-TO-SOURCE THRESHOLD VOLTAGE** vs JUNCTION TEMPERATURE 2.5 V<sub>GS(th)</sub> - Gate-to-Source Threshold Voltage - V $V_{DS} = V_{GS}$ 2 $I_D = 1 \text{ mA}$ 1.5 $I_D = 100 \, \mu A$ 1 0.5 80 100 120 140 160 -40 -20 40 60 T<sub>J</sub> - Junction Temperature - °C

Figure 5

### STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

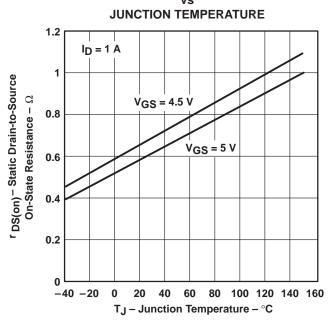


Figure 6



**DRAIN CURRENT** 

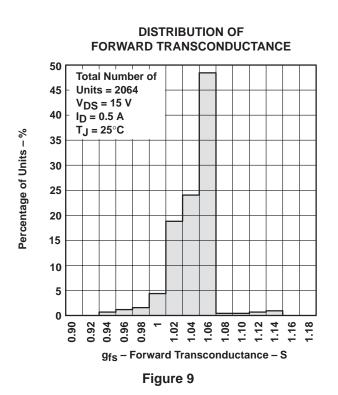
### TYPICAL CHARACTERISTICS

# STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE VS DRAIN CURRENT 10 T J = 25°C VGS = 4.5 V VGS = 5 V 0.1 0.1 1 10

ID - Drain Current - A

Figure 7

Figure 8



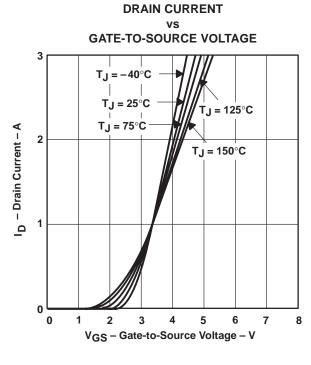


Figure 10

### TYPICAL CHARACTERISTICS

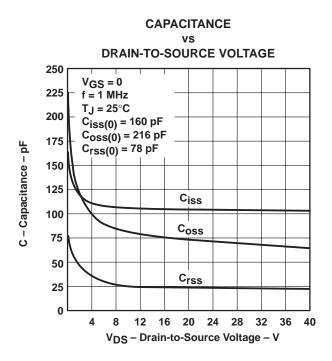
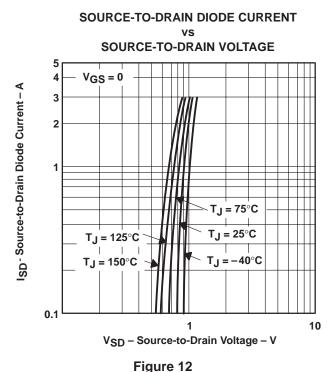


Figure 11

**DRAIN-TO-SOURCE VOLTAGE AND** 

### **GATE-TO-SOURCE VOLTAGE** vs **GATE CHARGE** 60 12 $I_D = 500 \text{ mA}$ T<sub>J</sub> = 25°C See Figure 3 50 VDS - Drain-to-Source Voltage - V 10 Gate-to-Source Voltage - V $V_{DD} = 20 \text{ V}$ 40 8 $V_{DD} = 30 V$ 30 6 20 4 $V_{DD} = 48 V$ 10 2 V<sub>DD</sub> = 20 V 0 0 0.5 2 2.5 3.5 1.5 3 Q<sub>q</sub> - Gate Charge - nC Figure 13





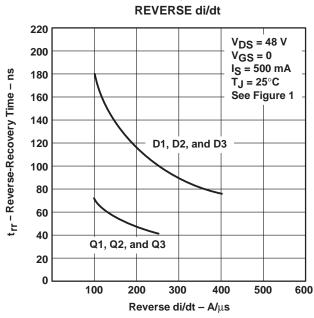
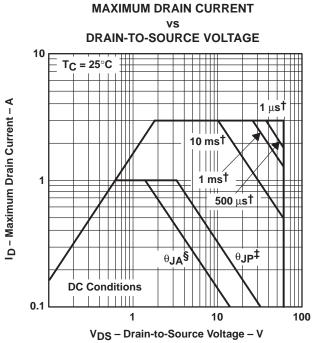


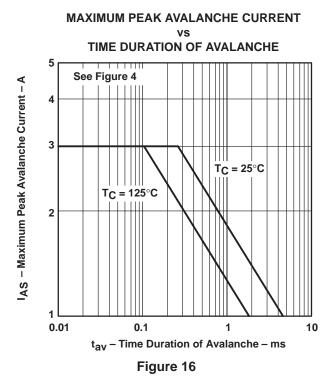
Figure 14

### THERMAL INFORMATION



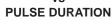
- †Less than 2% duty cycle
- ‡ Device mounted in intimate contact with infinite heatsink.
- § Device mounted on FR4 printed-circuit board with no heatsink.

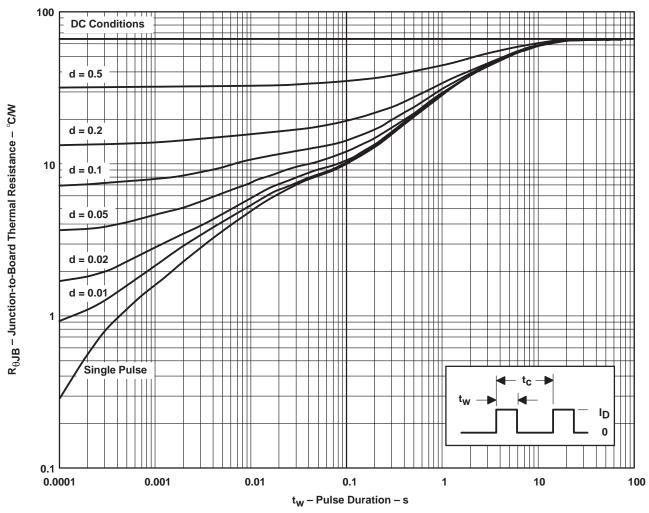
Figure 15



### THERMAL INFORMATION

# D PACKAGE† JUNCTION-TO-BOARD THERMAL RESISTANCE





† Device mounted on 24 in<sup>2</sup>, 4-layer FR4 printed-circuit board with no heatsink.

NOTE A:  $Z_{\theta B}(t) = r(t) R_{\theta JB}$   $t_W = \text{pulse duration}$   $t_C = \text{cycle time}$  $d = \text{duty cycle} = t_W/t_C$ 

Figure 17





### PACKAGE OPTION ADDENDUM

8-Apr-2005

### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp (3)
TPIC5323LD	OBSOLETE	SOIC	D	16	TBD	Call TI	Call TI

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND**: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

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(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# D (R-PDS0-G16)

### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



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